SPECIFICATION

SPEC. No. C-SoftC-a
D A T E: 2013 Sep.

То

Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS
C Series / Commercial Grade
Soft Termination

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE: YEAR MONTH DAY

TDK Corporation
Sales
Electronic Components
Sales & Marketing Group

TDK-EPC Corporation
Engineering

Ceramic Capacitors Business Group

APPROVED	Person in charge

APPROVED	CHECKED	Person in charge

1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan,

TDK (Suzhou) Co., Ltd and TDK Components U.S.A. Inc.

EXPLANATORY NOTE:

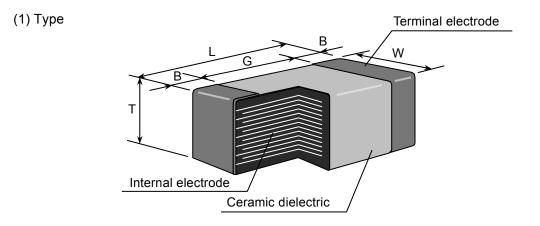
This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

2. CODE CONSTRUCTION

(Example)

Catalog Number : (Web)	C2012	X7R	<u>1C</u>	<u>475</u>	<u>M</u>	<u>125</u>	<u>A</u>	<u>E</u>
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)
Item Description :	C2012 (1)	X7R (2)	<u>1C</u> (3)	<u>475</u> (4)	<u>M</u> (5)	<u>T</u> (9)	<u>000S</u> (10)	



Please refer to product list for the dimension of each product.

(2) Temperature Characteristics (Details are shown in table 1 No.6 at page 5)

(3) Rated Voltage

Symbol	Rated Voltage	
2 J	DC 630 V	
2 W	DC 450 V	
2 E	DC 250 V	
2 A	DC 100 V	
1 H	DC 50 V	
1 V	DC 35 V	
1 E	DC 25 V	
1 C	DC 16 V	



(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

Example 475
$$\rightarrow$$
 4,700,000pF (4.7uF)

(5) Capacitance tolerance

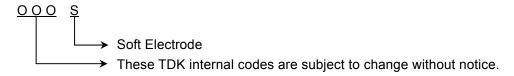
* M tolerance shall be TDK standard for over 10uF.

Symbol	Tolerance
K	± 10 %
М	± 20 %

- (6) Thickness code (Only Catalog Number)
- (7) Package code (Only Catalog Number)
- (8) Special code (Only Catalog Number)
- (9) Packaging (Only Item Description)

Symbol	Packaging
В	Bulk
Т	Taping

(10) TDK Internal code (Only Item Description)



3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

3.1 Standard combination of rated capacitance and tolerances

Temperature Characteristics	Capacitance tolerance	Rated capacitance
X7R X7S X7T	K (± 10 %) M (± 20 %)	E – 3 series

^{*} The standard capacitance tolerance is M (± 20 %).

3.2 Capacitance Step in E series

E series	Capacitance Step		
E- 3	1.0	2.2	4.7

4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating	Max. operating	Reference
	Temperature	Temperature	Temperature
X7R X7S X7T	-55°C	125°C	25°C

5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as C3225, C4532 and C5750 types are more likely to be affected by heat stress from the substrate. Please inquire separate specification for the large case sizes when mounted on the substrate.

7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.



8. PERFORMANCE

table 1

No.	Item	Per	formance	Test o	r inspection n	nethod
1	External Appearance	Al Appearance No defects which may affect Inspect with magnifying glass (3×).			s (3×).	
2	Insulation Resistance	10,000MΩ or 50 (As for the capa voltage 16V DC 100MΩ·μF min whichever small	acitors of rated c, 10,000 MΩ or .,)	Apply rated vo As for the rate 500V DC.	•	30V DC, apply
4	Voltage Proof Capacitance	Withstand test vinsulation break damage.	down or other	Rated voltage 100V and und Over 100V Above DC voltage / disches exceed 50mA. Rated Capacitance	der 2.5 × ra 1.5 × ra 2.6 × ra 2.7 × ra 2.8 × ra	
				10uF and under Over 10uF	1kHz±10% 120Hz±20%	1.0±0.2Vrms. 0.5±0.2Vrms.
5	Dissipation Factor	T.C. D.F. 0.03 max. X7R 0.05 max. 0.075 max. X7S 0.05 max.		See No.4 in thi	is table for me	easuring
				condition. For information	n which produ	ct has which
				Dissipation Factor, please contact with		
		X7T	0.025 max.	sales representative.		



No.	Item	Performance	Te	est or inspection method		
6	Temperature Characteristics	ics — Capacitance Change (%)		Capacitance shall be measured by the steps shown in the following table after		
	of Capacitance			quilibrium is obtained for each		
		X7R: ±15	step.			
			∆C be cal	culated ref. STEP3 reading		
		X7S: ±22	Step	Temperature(°C)		
		X7T: +22	1	Reference temp. ± 2		
		-33	2	Min. operating temp. ± 2		
			3	Reference temp. ± 2		
			4	Max. operating temp. ± 2		
7	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	P.C.Board Appendix of 5N with	Pushing force P.C.Board		
8	Bending	No mechanical damage.	a P.C.Boa bend it for	older the capacitors on ard shown in Appendix 2 and r 5mm. (2mm is applied for ad C5750.)		

No.	Ito	em	Perfo	ormance	Test or inspection method
9 Solderability		olderability New solder to cover over 75% of termination. 25% may have pin holes or rough		Completely soak both terminations in solder at 235±5°C for 2±0.5s.	
			-	oncentrated in one	Solder : H63A (JIS Z 3282)
			Ceramic surface shall not be exp		Flux : Isopropyl alcohol (JIS K 8839) Rosin(JIS K 5902) 25% solid solution.
10	Resistance	External	No cracks are a	llowed and	Completely soak both terminations in
	to solder	appearance	terminations sh	all be covered at	solder at 260±5°C for 5±1s.
	heat		least 60% with	new solder.	
		Capacitance	Characteristics	Change from the value before test	Preheating condition Temp.: 150±10°C Time: 1 to 2min.
	X7R X7S X7T ± 7.5 %		Flux : Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid		
		D.F.	Meet the initial spec.		- solution.
		Insulation Resistance	Meet the initial	spec.	Solder : H63A (JIS Z 3282) Leave the capacitors in ambient
	Voltage		No insulation breakdown or other damage.		condition for 24±2h before measurement

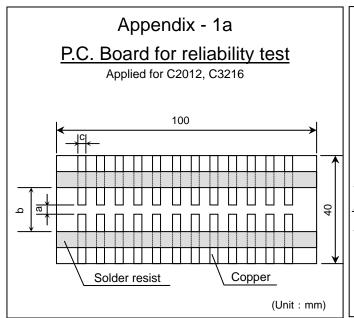
No.	Ite	em	Perf	ormance		Test or inspection m	ethod	
11	Vibration External appearance		No mechanical damage.		Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or			
		Capacitance D.F.	Characteristics X7R X7S X7T Meet the initial	Change from the value before test ± 7.5 % spec.	Vibrate 1.5mm from 1 about Repea	e the capacitors with P-P changing the from 0Hz to 55Hz and back 1min. It this for 2h each in 3 and cular directions.	amplitude of equencies ck to 10Hz in	
12	Temperature cycle	External appearance	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.		dix 1a or	
		Capacitance	Characteristics X7R X7S X7T	Change from the value before test ± 7.5 %	Expos	pose the capacitors in the condition through step 4 and repeat 5 times accutively.		
		D.F.	Meet the initial	spec.	Leave the capacitors in ambient condition for 24±2h before measurement.		bient	
	Insulation Resistance		Meet the initial	spec.	Step	Temperature(°C)	Time (min.)	
		Voltage proof	No insulation breakdown or other damage.		1	Min. operating temp. ±3	30 ± 3	
					2	Reference Temp.	2 - 5	
					3	Max. operating temp. ±2	30 ± 2	
					4	Reference Temp.	2 - 5	

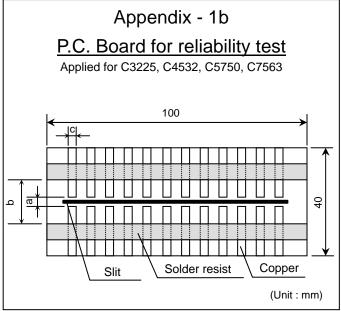
No.	Ite	em	Perf	ormance	Test or inspection method
13	Moisture Resistance	External appearance	No mechanical damage.		Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or
	(Steady State)	Capacitance	Characteristics	Change from the	Appendix 1b before testing.
			X7R X7S X7T	value before test ± 12.5 %	Leave at temperature 40±2°C, 90 to 95%RH for 500 +24,0h.
		D.F.	Characteristics X7R/X7S/X7T : 200% of init		Leave the capacitors in ambient condition for 24±2h before measurement.
		Insulation Resistance	1,000MΩ or 50M (As for the capa voltage 16V DC 10MΩ·μF min., whichever sma	acitors of rated C , 1,000 M Ω or	

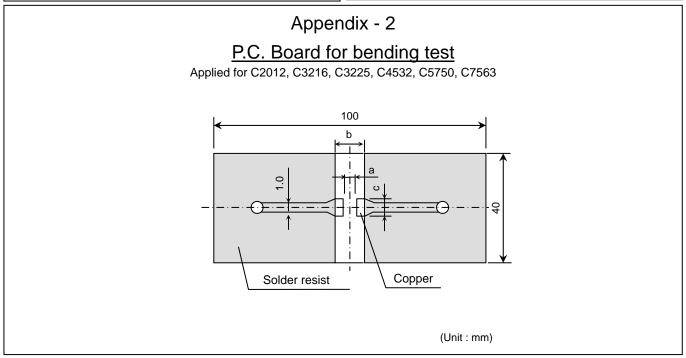
No.	Ite	em	Performance		Test or inspection method	
	loisture tesistance	External appearance	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or	
R	resistance	D.F. Insulation Resistance	Characteristics X7R X7S X7T Characteristics X7R/X7S/X7T : 200% of initi 500MΩ or 25MΩ (As for the capa voltage 16V DC 5MΩ·μF min.,) whichever smal	Ω·μF min. acitors of rated c, 500 MΩ or	P.C.Board shown in Appendix 1a or Appendix 1b before testing. Apply the rated voltage at temperature 40±2°C and 90 to 95%RH for 500 +24,0h. Charge/discharge current shall not exceed 50mA. Leave the capacitors in ambient condition for or 24±2h before measurement. Voltage conditioning Voltage treat the capacitors under testing temperature and voltage for 1 hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.	

No.	Item	Performance		Test or inspection method	
15 Life	External appearance	No mechanical	damage.	Reflow solder the capacitors on a P.C.Board shown in Appendix 1a or Appendix 1b before testing.	
	Capacitance	Characteristics	Change from the value before test	Below the voltage shall be applied at	
		X7R X7S	± 15 %	125±2°C for 1,000 +48, 0h.	
		X7T		Applied voltage	
				Rated voltage x2	
	D.F.	Characteristics		Rated voltage x1.5	
		X7R/X7S/X7T		Rated voltage x1.2	
		: 200% of initial spec. max		Rated voltage x1	
	Insulation Resistance	1,000MΩ or 50N (As for the cap voltage 16V DC 10MΩ·μF min., whichever small	acitors of rated C, 1,000 MΩ or)	For information which product has which applied voltage, please contact with our sales representative. Charge/discharge current shall not exceed 50mA. Leave the capacitors in ambient condition for 24±2h before measurement. Voltage conditioning Voltage treat the capacitors under testing temperature and voltage for 1 hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value	

^{*}As for the initial measurement of capacitors on number 8,12,13,14 and 15, leave capacitors at 150 –10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.







Material: Glass Epoxy (As per JIS C6484 GE4)

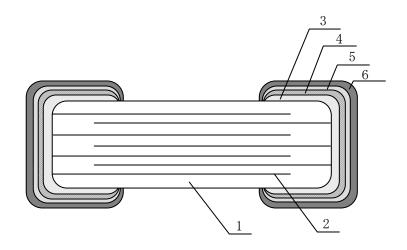
P.C. Board thickness: Appendix-1a, 1b, 2 1.6mm

Copper (thickness 0.035mm)
Solder resist

TDV (FIA atula)	Dimensions (mm)			
TDK (EIA style)	а	b	С	
C2012 (CC0805)	1.2	4.0	1.65	
C3216 (CC1206)	2.2	5.0	2.0	
C3225 (CC1210)	2.2	5.0	2.9	
C4532 (CC1812)	3.5	7.0	3.7	
C5750 (CC2220)	4.5	8.0	5.6	
C7563 (CC3025)	5.5	9.1	6.9	



9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL
1	Dielectric	BaTiO₃
2	Electrode	Nickel (Ni)
3		Copper (Cu)
4	Termination	Conductive resin (Filler : Ag)
5	Termination	Nickel (Ni)
6		Tin (Sn)

10. RECOMMENDATION

As for C3225, C4532, C5750 and C7563 types, It is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing Flux. And please make sure to dry detergent up completely before.

11. SOLDERING CONDITION

As for C3225, C4532, C5750 and C7563 types, reflow soldering only.



12. Caution

	Caution			
No.	Process	Condition		
1	Operating Condition (Storage,	1-1. Storage1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.		
	Transportation)	 The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur. 		
		3) Avoid storing in sun light and falling of dew.		
		4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.		
		5) Capacitors should be tested for the solderability when they are stored for long time.		
		1-2. Handling in transportation		
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation)		
2	Circuit design A Caution	 2-1. Operating temperature		
		2) Surface temperature including self heating should be below maximum operating		
		temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)		
		 The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration. Operating voltage Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. 		
		AC or pulse with overshooting, V _{P-P} must be below the rated voltage.		
		When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.		
		Voltage (1) DC voltage (2) DC+AC voltage (3) AC voltage		
		Positional Measurement (Rated voltage) 0 V _{0-P} 0 V _{P-P} 0		
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)		
		Positional Measurement (Rated voltage)		



No.	Process	Condition					
2	Circuit design A Caution		he rated voltage of the capacitors			or pulse is applied,	
		 The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration. 					
			apacitors (Class 2 nay vibrate thems	•	•	•	
3	Designing P.C.board	capacitors. 1) The greater the and the more shape and size terminations.	1) The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the				
			ommon solder la r each terminatio		erminations and	provide individual	
		3) Size and reco	mmended land	dimensions.			
			C	Chip capacitors	Solder land		
		Solder resist				Solder resist	
		B A					
		Flow solder	-		nm)		
		Type Symbol	C2012 (CC0805)	C3216 (CC1206)		
		А	1.0 - 1.3	2.1 - 2.5			
		B	1.0 - 1.2	1.1 - 1.3			
		C	0.8 - 1.1	1.0 - 1.3	<u> </u>		
		Reflow sold	ering	(mm)			
		Type Symbol	C2012 (CC0805)	C3216 (CC1206)			
		A	0.9 - 1.2	2.0 - 2.4			
		В	0.7 - 0.9	1.0 - 1.2			
		C	0.9 - 1.2	1.1 - 1.6			
		Type Symbol	C3225 (CC1210)	C4532 (CC1812)	C5750 (CC2220)	C7563 (CC3025)	
		А	2.0 - 2.4	3.1 - 3.7	4.1 - 4.8	5.2 – 5.8	
		В	1.0 - 1.2	1.2 - 1.4	1.2 - 1.4	1.7 - 1.9	
		C	1.9 - 2.5	2.4 - 3.2	4.0 - 5.0	6.4 – 7.4	



No.	Drococc		Condition	
No. 3	Process Designing P.C.board	4) Recommended	Condition chip capacitors layout is as follows:	wing.
	1.0.00010		Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit Break P.C.board with	Perforation or slit Break P.C.board with
			mounted side up.	mounted side down.
		Chip arrangement (Direction)	Mount perpendicularly to perforation or slit Perforation or slit	Mount in parallel with perforation or slit Perforation or slit
		Distance from slit	Closer to slit is higher stress $(\mathcal{L}_1 < \mathcal{L}_2)$	Away from slit is less stress ℓ_2 $(\ell_1 < \ell_2)$

Condition No. **Process** 3 5) Mechanical stress varies according to location of chip capacitors on the P.C.board. Designing P.C.board E Perforation 00000 00000 В Slit The stress in capacitors is in the following order. A > B = C > D > E6) Layout recommendation Use of common Use of common Soldering with Example solder land with solder land chassis other SMD Lead wire Chassis Solder Excessive solder chip Solder Need to avoid Excessive solder PCB Adhesive Solder land Missing Solder land solder Lead wire Solder resist Solder resist Recommendation



Solder resist

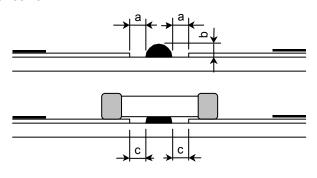
 $\ell^2 > \ell^1$

No.	Process	Condition			
4	Mounting	capacitors to res 1) Adjust the bottom surface and no 2) Adjust the mountain and the moun	nead is adjusted too low, it may in ult in cracking. Please take following the mounting heat press it. Inting head pressure to be 1 to 3N is impact energy from mounting heat bottom side of the P.C.board.	ng precautions. ead to reach on the P.C.board of static weight.	
			Not recommended	Recommended	
			8		

	Not recommended	Recommended
Single sided mounting	Crack	Support pin
Double-sides mounting	Solder peeling Crack	Support pin

When the centering jaw is worn out, it may give mechanical impact on the capacitors to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.

4-2. Amount of adhesive



Example: C2012 (CC0805), C3216 (CC1206)

а	0.2mm min.
b	70 - 100μm
c Do not touch the solder lan	



No.	Process		C	ondition					
5	Soldering	 5-1. Flux selection Although highly-activated flux gives better solderability, substances which increase activity may also degrade the insulation of the chip capacitors. To avoid such degradation, it is recommended following. 1) It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. 2) Excessive flux must be avoided. Please provide proper amount of flux. 3) When water-soluble flux is used, enough washing is necessary. 							
		5-2. Recommended soldering profile by various methods							
		Wave soldering Reflow soldering							
		Peak Temp O Over 60 sec. Peak Temp Manual S (Solde	Over 60 sec. The time soldering or iron)	APPL As for (CC12 reflow As for C5750 only to	Preheating So Preheating r 60 sec.	Natural cooling Natural coolin			
		5-3. Recommended sold	ering peak temp	and peak tem	p duration				
		Temp./buration	Wave so	oldering	Reflow so	oldering			
		Solder	Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)			
		Sn-Pb Solder 250 max. 3 max. 230 max. 2							
		Lead Free Solder	260 max.	5 max.	260 max.	10 max.			
		Recommended solde Sn-37Pb (Sn-Pb sol Sn-3.0Ag-0.5Cu (Le	lder))					

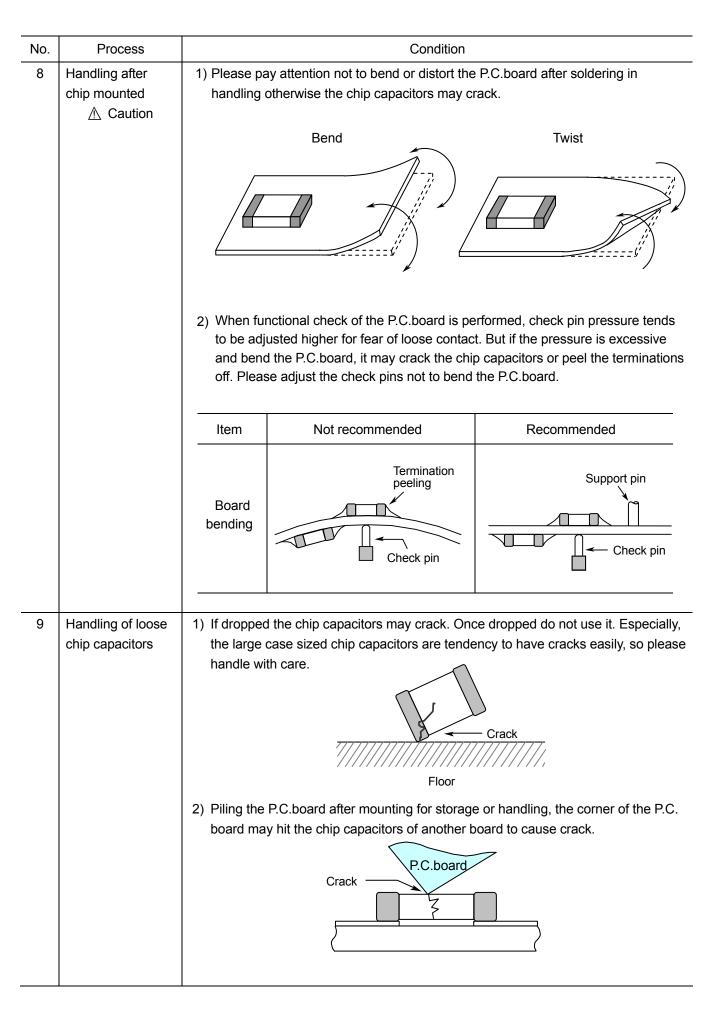


No.	Process	Condition					
5	Soldering	5-4. Avoiding thermal shock	k				
		1) Preheating condition					
		Soldering		Туре	Temp. (°C)		
		Wave soldering	C2012(CC0805),	C3216(CC1206)	ΔT ≤ 150		
			C2012(CC0805),	C3216(CC1206)	ΔT ≤ 150		
		Reflow soldering	C3225(CC1210), C5750(CC2220),	, ,,	ΔT ≤ 130		
			C2012(CC0805),	C3216(CC1206)	ΔT ≤ 150		
		Manual soldering	C3225(CC1210), C5750(CC2220),		ΔT ≤ 130		
		5-5. Amount of solder					
			es and it may resu	ılt in chip cracking	n chip capacitors w j. In sufficient solder i		
		Excessive solder	/ Chip capacitors to cause				
		Adequate		Maximum Minimum			
		Insufficient solder		caus chip	robustness may se contact failure or capacitors come off P.C.board.		
		5-6. Solder repair by solder 1) Selection of the soldering Tip temperature of sold land size. The higher the heat shock may cause Please make sure the time in accordance with chip capacitors with the solder of t	ng iron tip der iron varies by the tip temperature a crack in the ch tip temp. before s th following recom e condition in 5-4	e, the quicker the open ip capacitors. Soldering and keep mended condition to avoid the therm	operation. However the peak temp and h. (Please preheat the hal shock.)		
		Recommended solde Temp. (°C)	er iron condition (S Duration (sec.)	Sn-Pb Solder and I Wattage (W)	Lead Free Solder) Shape (mm)		
		lemp. (C)	Daration (360.)	vvallage (vv)	Shape (min)		
		300 max.	3 max.	20 max.	Ø 3.0 max.		



No.	Process	Condition
5	Soldering	 Direct contact of the soldering iron with ceramic dielectric of chip capacitors may cause crack. Do not touch the ceramic dielectric and the terminations by solder iron.
		5-7. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder.
		5-8. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335B Annex 1 (Informative) Recommendations to prevent the tombstone phenomenon)
6	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing (1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/ ℓ max. Frequency : 40 kHz max. Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
7	Coating and	1) When the P.C.board is coated, please verify the quality influence on the product.
	molding of the P.C.board	2) Please verify carefully that there is no harmful decomposing or reaction gas
		emission during curing which may damage the chip capacitors.





No.	Process	Condition
10	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient: 3 multiplication rule, Temperature acceleration coefficient: 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.
12	Others A Caution	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (cars, electric trains, ships, etc.) (3) Medical equipment (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.



13. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example
$$\underline{M}$$
 $\underline{1}$ \underline{A} - \underline{OO} - \underline{OOO} (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

14. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging: 1,000pcs.

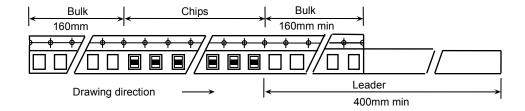
15. TAPE PACKAGING SPECIFICATION

1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3. Dimensions of plastic tape shall be according to Appendix 4, 5, 6.

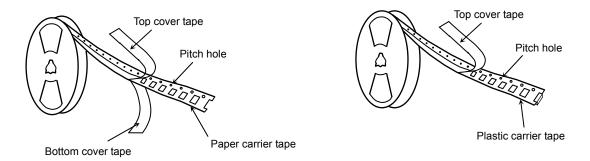
1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8. Dimensions of Ø330 reel shall be according to Appendix 9, 10, 11.

1-4. Structure of taping



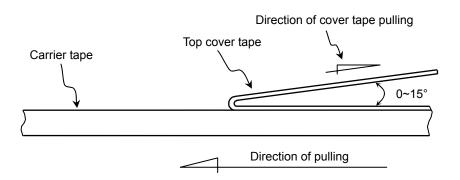


2. CHIP QUANTITY

Typo	Thickness	Taping	Chip quantity(pcs.)		
Туре	of chip	Material	φ178mm reel	φ330mm reel	
C2012	0.85 mm	Paper	4,000	10.000	
C2012	1.25 mm	Plastic	2,000	10,000	
	1.15 mm			10.000	
C3216	1.30 mm	Plastic	2,000	10,000	
	1.60 mm			8,000	
	1.60 mm		2,000	8,000	
C3225	2.00 mm	Plastic			
C3225	2.30 mm	Flastic	1,000	5,000	
	2.50 mm				
	2.00 mm		1,000		
C4532	2.30 mm	Plastic	500	3,000	
	2.50 mm		300		
C5750	2.30 mm	Plastic	500	3 000	
C5750	2.50 mm	FiaStic	500	3,000	
C7563	2.5 max	Plastic		1 000	
	3.0 max	าเสอแบ		1,000	

3. PERFORMANCE SPECIFICATIONS

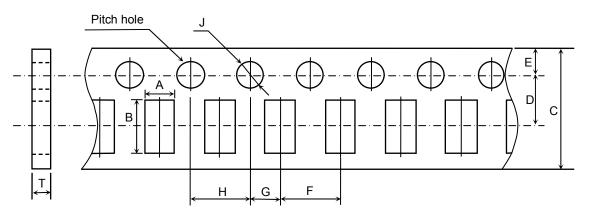
3-1. Fixing peeling strength (top tape) 0.05-0.7N. (See the following figure.)



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.



Paper Tape

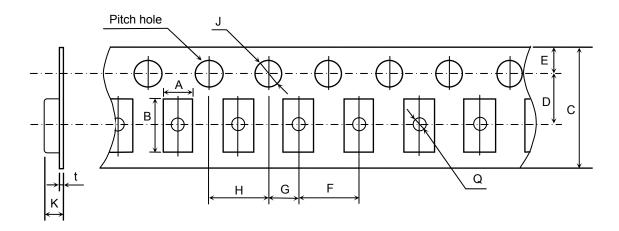


(Unit: mm)

Symbol Type	А	В	С	D	E	F
C2012 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
Symbol Type	G	Н	J	Т		
C2012 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 ${+0.10} \atop 0$	1.10 max.		

^{*} The values in the parentheses () are for reference.

Plastic Tape



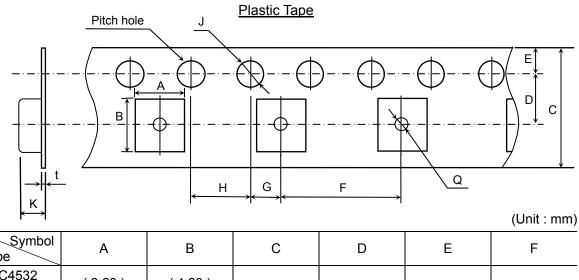
(Unit:mm)

Symbol Type	А	В	С	D	E	F
C2012 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05		
C3216 (CC1206)	(1.90)	(3.50)	0.00 1 0.00	0.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3225 (CC1210)	(2.90)	(3.60)	8.00 ± 0.30 or 12.0 ± 0.30	3.50 ± 0.05 or 5.50 ± 0.05		
Symbol Type	G	Н	J	К	t	Q
C2012 (CC0805)				2.50 max.		
C3216 (CC1206)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	2.00 max.	0.60 max.	Ø 0.50 min.
C3225 (CC1210)				3.20 max.		

^{*} The values in the parentheses () are for reference.



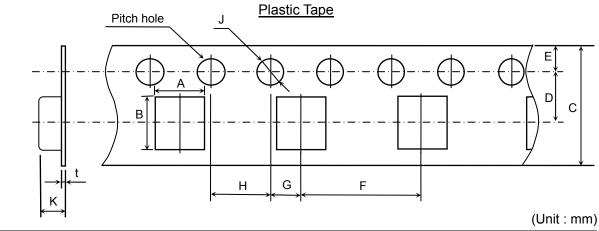
^{*} Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.



Symbol Type	А	В	С	D	E	F
C4532 (CC1812)	(3.60)	(4.90)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
C5750 (CC2220)	(5.70)	(6.40)	12.0 ± 0.50	5.50 ± 0.05	1.75 ± 0.10	6.00 ± 0.10
Symbol Type	G	Н	J	К	t	Q
C4532 (CC1812)			Q 1 5 +0.10			
(001012)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	6.50 max.	0.60 max.	Ø 1.50 min.

^{*} The values in the parentheses () are for reference.

Appendix 6

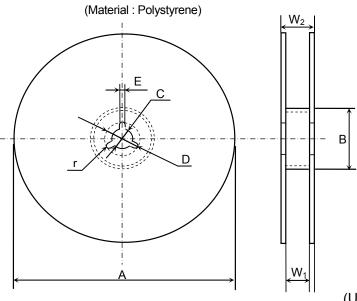


						(•••••)
Symbol Type	А	В	С	D	E	F
C7563 (CC3025)	(6.9)	(8.0)	16.0±0.3	7.5±0.1	1.75±0.1	12.0±0.1
Symbol Type	G	Н	J	К	t	
C7563 (CC3025)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	6.50 max.	0.60 max.	

^{*} The values in the parentheses () are for reference.



C2012, C3216, C3225



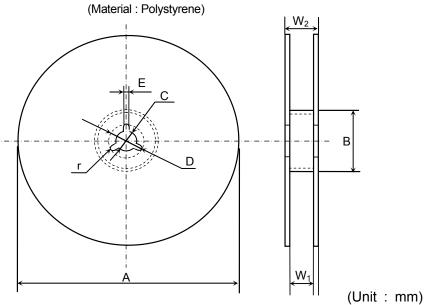
(Unit: mm)

Symbol	А	В	С	D	E	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W ₂	r		
Dimension	13.0 ± 1.4	1.0		

Appendix 8

C3225 12mm width taping type, C4532, C5750



Symbol	Α	В	С	D	Е	W_1
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3

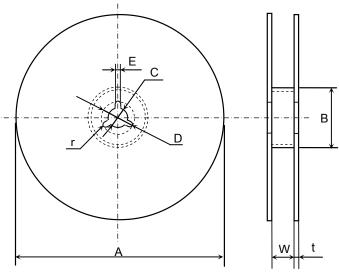
Symbol	W_2	r
Dimension	17.0 ± 1.4	1.0





C2012, C3216, C3225

(Material : Polystyrene)



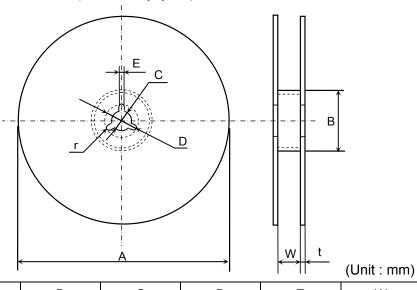
				1		(Unit:mm)
Symbol	Α	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0

Appendix 10

C3225 12mm width taping type, C4532, C5750

(Material : Polystyrene)

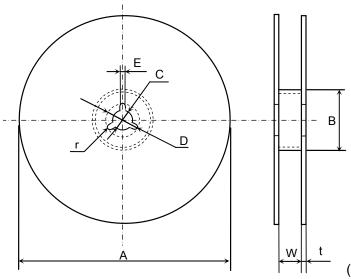


Symbol	А	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0

C7563





	ŀ	•	Α		₩ · ·	(Unit : mm)
Symbol	Α	В	С	D	Е	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	17.5 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0